

Search Notes

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Examiner

EDMUND H. LEE

Applicant(s)/Patent under
Reexamination

MASER ET AL.

Art Unit

1791

SEARCHED

Class	Subclass	Date	Examiner
UPDATED		5/26/2008	EHL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
264	400,482	5/26/2008	EHL
	154		
426	140,105		
426/415,410			

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
UPDATED	5/26/2008	EHL
264/400,482,154		
426/140,105,415,410		